Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/728,531	LAI ET AL.		
Examiner	Art Unit	•	
Tae H. Yoon	1714		

SEARCHED			
Class	Subclass	Date	Examiner
523	107	8-18-05	ly
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424	422		
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351	160R	1-6-06	re
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
523	101	2-23-08	3		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST Inventor Search	8-10-et 8-10-65	ay	
Inventor Search	8-20-65		
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